Form PTO 1449	U.S. DEPARTMENT OF COMMERCE			ATTY DOCKET NO.		SERIAL NO.		
(Modified)		PATENT AND TR	ADEMARK OFFICE	232989US0		New U.S. Application		
LIST OF REFERENCES CITED BY APPLICANT			APPLICANT					
			Claude DUBIEF, et al.					
				FILING DATE		GROUP		
				Herewith				
U.S. PATENT DOCUMENTS								
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE	
/LW/	AA	5,298,240	03/29/94	SCHROEDER, et al.				
/LW/	AB	5,468,725	11/21/95	GUENIN, et al.				
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/LW/	AD	2002/0098215	07/25/02	DOUIN, et al.				
	AE							
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	AK							
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	AM							
	AN							
FOREIGN PATENT DOCUMENTS								
	-	DOCUMENT	DATE	COUNTRY			TRANSLATION	
/LW/	•	NUMBER	<u> </u>	Germany w/computer generated Englis	h	YES	NO NO	
	AO	197 10 155	09/17/98	translation				
/LW/	AP	0 820 758	01/28/98		ope w/computer generated English translation			
/LW/	AQ	1 129 684	09/05/01	Europe which corresponds to 2001/002	8887A1	· · · · · · · · · · · · · · · · · · ·	·.	
/LW/ /LW/	AR	01/56537	08/09/01	WIPO				
/LVV/	AS	1 120 102	08/01/01	Europe which corresponds to US 2002/	S 2002/098215			
	AT		 					
	AU		 				•	
	AV							
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)								
	AW							
	AX							
	AY							
	AZ				Additional References sheet(s) attached			
Examiner	/Leonard Williams/ (01/02/2008)				Date Considered			
*Examiner: Ini conformance :	*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							